

N-Ch MOSFET

General Description

The WSR80N08 is the highest performance trench N-ch MOSFET with extreme high cell density,which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications .

The WSR80N08 meet the RoHS and Green Product requirement,100% EAS guaranteed with full function reliability approved.

Product Summery

BV _{DSS}	R _{DSON}	Ι _D
80V	8.4mΩ	80A

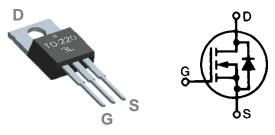
Applications

- Power Management
- DC/DC Converter
- Load Switch

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

TO-220AB Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
V _{DS}	Drain-Source Voltage 80		V	
V _{GS}	Gate-Source Voltage	± 20	V	
I _D	T_{C} = 25°Continuous Drain Current. Lead current limit.	80	А	
I _{DM}	$T_{\rm C}$ = 25°C,pulse width limited by $T_{\rm JM}$ 75		А	
I _{AR}	$T_{\rm C}$ = 25°C,Avalanche Current. 320		А	
E _{AR}	TC = 25°C,Single Pulse Avalanche Energy ³ 30		mJ	
E _{AS}	TC = 25°C,Single Pulse Avalanche Energy ³	1.0	J	
PD	TC = 25°C,Total Power Dissipation ⁴	230	W	
TJ	Operating Junction Temperature Range -55 to 175		°C	
T _{JM}	Storage Temperature Range	-55 to 175	°C	
TJ	MAX Junction Temperature Range	175	°C	
R _{θJA}	Thermal Resistance Junction-Ambient ¹	62	°C/W	
R _{θJC}	Thermal Resistance Junction-Case ¹	0.65	°C/W	



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Electrical Characteristics (TJ=25 C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I _D =250uA	80			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\!{\rm C}$, $I_D {=} 1 mA$		0.096		V/℃
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V,I _D =40A.		8.4	9.5	mΩ
V _{GS(th)}	Gate Threshold Voltage	──	2.0		4.0	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-5.5		mV/℃
I _{DSS}	Drain-Source Leakage Current	V_{DS} =55V , V_{GS} =0V , TJ=25 $^\circ\!\!\mathbb{C}$			50	uA
		V_{DS} =55V , V_{GS} =0V , T _J =85 $^\circ$ C			1000	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, V_{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =10V , I _D =40A	35	55		S
R _g	Gate Resistance	V_{DS} =0V , V_{GS} =0V , f=1MHz		1.8	3.8	Ω
Qg	Total Gate Charge (10V)	V _{DS} =60V,V _{GS} =10V,I _D =40A		180		
Q _{gs}	Gate-Source Charge			42		nC
Q _{gd}	Gate-Drain Charge			75		
T _{d(on)}	Turn-On Delay Time			50		
Tr	Rise Time	V_{DS} =60V, V_{GS} =10V ,		75		20
T _{d(off)}	Turn-Off Delay Time	R _G =2.5Ω, I _D =40A.		95		ns
T _f	Fall Time			31		
C _{iss}	Input Capacitance			4800		
Coss	Output Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		1670		рF
C _{rss}	Reverse Transfer Capacitance			590		

Diode Characteristics(T_J = 25°C, unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _{GS} =0V,			80	А
I _{SM}	Pulsed Source Current ^{2,6}	pulse width limited by $T_{\mbox{\tiny JM}}$			320	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =I _F . Note2			1.5	V
t _{rr}	Reverse Recovery Time	- I _⊧ =25A,dı/d _t =100A/µs.		200		nS
Qrr	Reverse Recovery Charge	$r_{\rm F}$ = 23A, $u_{\rm F}u_{\rm f}$ = 100A/ μ 3.		500		nC

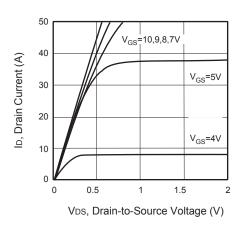
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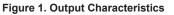
- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<=10sec.
- 2. The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%
- 3. The EAS data shows Max. rating . The test condition is $V_{\text{DS}}\text{=}25\text{V}, V_{\text{GS}}\text{=}10\text{V}, \text{L=}0.1\text{mH}, \text{I}_{\text{AS}}\text{=}25\text{A}$
- 4. The power dissipation is limited by $150\,^\circ\!\mathrm{C}$ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





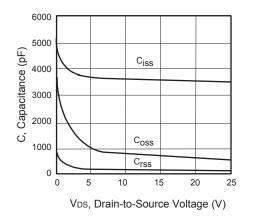


Figure 3. Capacitance

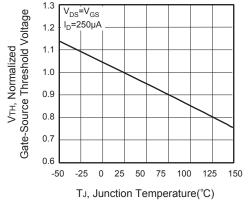


Figure 5. Gate Threshold Variation with Temperature

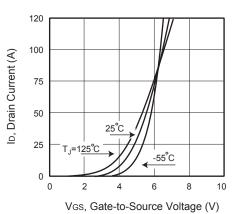


Figure 2. Transfer Characteristics

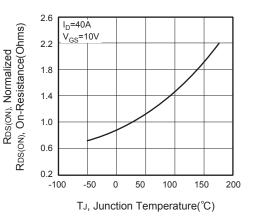
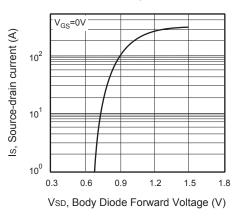
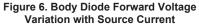


Figure 4. On-Resistance Variation with Temperature

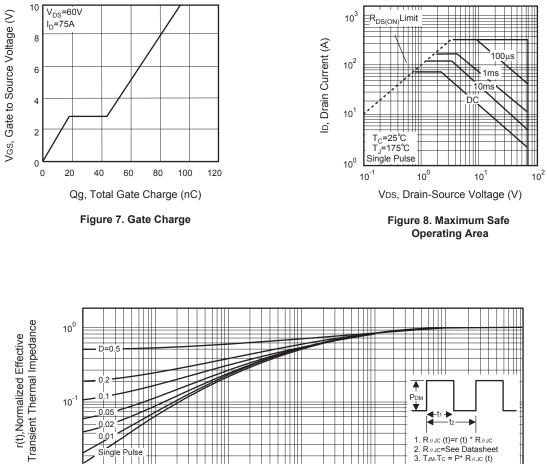






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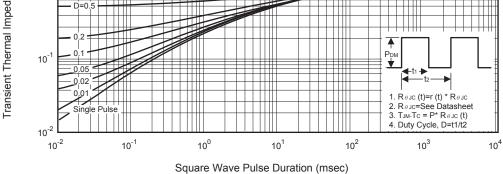


Figure 9. Normalized Thermal Transient Impedance Curve



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